

Quarterly Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2023

Based on structural similarity

Supplier Nexperia B.V. Name of Laboratory Assembly reliability labs Based on AEC-Q101 Test		User Part Number PESD30VF1BBL-Q Part Description											
									Nexperia DHAM Protection Bipolar				
									MCD package				
		Test Conditions	Duration	# Lots	# Quantity	# Rejects							
		TI	EST										
		Pr	re- and Post-Stress										
# E1 EI	ectrical Test	Tamb = 25 °C	N/A	see below	all parts	see below							
P 0 # A1 Pr	C reconditioning	JESD22-A113 Bake Tamb = 125 °C Soak Tamb = 85 °C, RH = 85% Reflow soldering	24 hours 168 hours 3 cycles	228	10140	0							
H Hi	TRB	MIL-STD-750-1 M1038 Method A Tj = Tjmax, Vr = 100% of max. datasheet reverse voltage	1000 hours	45	2000	0							
Τ (# Α4 Τε	C emperature Cycling	JESD22-A104 -65 °C to Tjmax, not to exceed 150°C	1000 cycles	86	3830	0							
	HAST nbiased HAST	JESD22-A118 Tamb = 130 °C, RH = 85 %	— 96 hours	59	2615	0							
A # A3 alt A	C utoclave	JESD22-A102 Tamb = 121 °C, RH = 100 % Pressure = 205 kPa (29.7 psia)											
Hi	3TRB igh Humidity High emperature Reverse Bias	JESD22-A101 Tamb = 85 °C, RH = 85%, VR = 80 % of rated reverse voltage $^{[1]}$	1000 hours	83	3695	0							
	DL htermittent Operating Life	MIL-STD-750 Method 1037 ton = toff, devices powered to insure $\Delta Tj = 100$ °C for 15000 cycles	1000 hours	n.a.	n.a.	n.a.							
	SH esistance to Solder Heat	JESD22-A111 260 °C ± 5 °C	10 s	n.a.	n.a.	n.a.							
# C10 Sc	D olderability	J-STD-002		32	960	0							

^[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Wafer Fab	Technology	Quantity	Rejects	Failure Rate (FIT)	MTTF (hrs)
Nexperia					
DHAM	Protection Bipolar	2000	0	2,12	4,71E+08

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